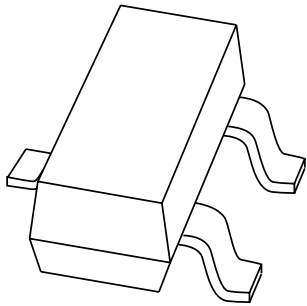


DATA SHEET



BAP1321-04

FEATURES

- High voltage, current controlled
- RF resistor for RF attenuators and switches
- Low diode capacitance
- Low diode forward resistance
- Very low series inductance
- For applications up to 3 GHz.

APPLICATIONS

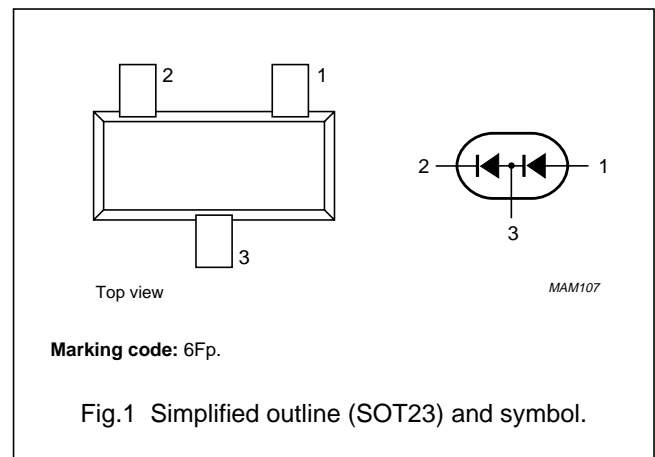
- RF attenuators and switches.

DESCRIPTION

Two planar PIN diodes in series configuration in a SOT23 small SMD plastic package.

PINNING

PIN	DESCRIPTION
1	anode
2	cathode
3	common connection



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per diode					
V_R	continuous reverse voltage		–	60	V
I_F	continuous forward current		–	100	mA
P_{tot}	total power dissipation	$T_s \leq 90\text{ °C}$	–	250	mW
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–65	+150	°C

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ELECTRICAL CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
Per diode					
V_F	forward voltage	$I_F = 50\text{ mA}$	0.95	1.1	V
I_R	reverse leakage current	$V_R = 60\text{ V}$	–	100	nA
C_d	diode capacitance	$V_R = 0; f = 1\text{ MHz}$	0.42	–	pF
		$V_R = 1\text{ V}; f = 1\text{ MHz}$	0.375	0.45	pF
		$V_R = 20\text{ V}; f = 1\text{ MHz}$	0.275	0.325	pF
r_D	diode forward resistance	$f = 100\text{ MHz}$; note 1			
		$I_F = 0.5\text{ mA}$	3.4	5.0	Ω
		$I_F = 1\text{ mA}$	2.4	3.6	Ω
		$I_F = 10\text{ mA}$	1.2	1.8	Ω
$ S_{21} ^2$	isolation	$V_R = 0; f = 900\text{ MHz}$	15.7	–	dB
		$V_R = 0; f = 1800\text{ MHz}$	10.5	–	dB
		$V_R = 0; f = 2450\text{ MHz}$	7.9	–	dB
$ S_{21} ^2$	insertion loss	$I_F = 0.5\text{ mA}; f = 900\text{ MHz}$	0.27	–	dB
		$I_F = 0.5\text{ mA}; f = 1800\text{ MHz}$	0.35	–	dB
		$I_F = 0.5\text{ mA}; f = 2450\text{ MHz}$	0.43	–	dB
$ S_{21} ^2$	insertion loss	$I_F = 1\text{ mA}; f = 900\text{ MHz}$	0.21	–	dB
		$I_F = 1\text{ mA}; f = 1800\text{ MHz}$	0.29	–	dB
		$I_F = 1\text{ mA}; f = 2450\text{ MHz}$	0.37	–	dB
$ S_{21} ^2$	insertion loss	$I_F = 10\text{ mA}; f = 900\text{ MHz}$	0.14	–	dB
		$I_F = 10\text{ mA}; f = 1800\text{ MHz}$	0.21	–	dB
		$I_F = 10\text{ mA}; f = 2450\text{ MHz}$	0.29	–	dB
$ S_{21} ^2$	insertion loss	$I_F = 100\text{ mA}; f = 900\text{ MHz}$	0.10	–	dB
		$I_F = 100\text{ mA}; f = 1800\text{ MHz}$	0.18	–	dB
		$I_F = 100\text{ mA}; f = 2450\text{ MHz}$	0.26	–	dB
τ_L	charge carrier life time	when switched from $I_F = 10\text{ mA}$ to $I_R = 6\text{ mA}$; $R_L = 100\text{ }\Omega$; measured at $I_R = 3\text{ mA}$	0.5	–	μs
L_S	series inductance	$I_F = 100\text{ mA}; f = 100\text{ MHz}$	1.4	–	nH

Note

1. Guaranteed on AQL basis: inspection level S4, AQL 1.0.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j-s}$	thermal resistance from junction to soldering point	220	K/W